


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/652,138	TANAKA, KOICHIRO	
	Examiner	Art Unit	
	Zohreh A. Fay	1618	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
The parent application was reviewed	8/30/2006	Z.F
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